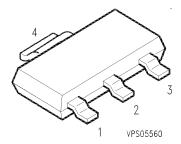
Preliminary data

SIPMOS Power Transistor

- P-Channel
- Enhancement mode
- Avalanche rated
- Logic Level
- dv/dt rated



Pin 1	Pin2/4	Pin 3
G	D	S

Туре	V _{DS}	I _D	R _{DS(on)}	@ VGS	Package	Ordering Code
BSP 171 P	-60 V	-1.8 A	0.3 Ω	$V_{GS} = -10 \text{ V}$	P-SOT223-4-1	Q67041-S4019
					-	-

Maximum Ratings, at T_i = 25 °C, unless otherwise specified

Parameter	Symbol	Value	Unit
Continuous drain current	I _D		А
<i>T</i> _A = 25 °C		-1.8	
$T_{A} = 100 ^{\circ}\text{C}$		-1.15	
Pulsed drain current	I _{D puls}	-7.2	
$T_A = 25 ^{\circ}\text{C}$			
Avalanche energy, single pulse	E _{AS}	70	mJ
$I_{\rm D}$ = -1.8 A, $V_{\rm DD}$ = -25 V, $R_{\rm GS}$ = 25 Ω			
Avalanche current, periodic limited by T_{jmax}	I _{AR}	-1.8	Α
Avalanche energy, periodic limited by $T_{j(max)}$	E _{AR}	0.18	mJ
Reverse diode dv/dt	d <i>v</i> /d <i>t</i>	6	KV/µs
$I_{S} = -1.8 \text{ A}, \ V_{DD} \le V_{(BR)DSS}, \ di/dt = 100 \ A/\mu s,$			
_T _{imax} = 150 °C			
Gate source voltage	V_{GS}	±14	V
Power dissipation, $T_A = 25 ^{\circ}\text{C}$	P_{tot}	1.8	W
Operating temperature	T_{j}	-55+150	°C
Storage temperature	T _{stg}	-55+150	
IEC climatic category; DIN IEC 68-1		55/150/56	

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Electrical Characteristics						
Parameter	Symbol	Values			Unit	
at $T_i = 25$ °C, unless otherwise specified		min.	typ.	max.		
Thermal Characteristics	·					

Thermal resistance, junction -soldering point (Pin 4)	R_{thJS}	-	tbd	tbd	K/W
Thermal resistance, junction - ambient	R_{thJA}	-	-	ı	
SMD version, device on PCB:	R_{thJA}				
@ min. footprint		-	tbd	-	
@ 6 cm ² cooling area ^{F)}		-	tbd	70	

Static Characteristics

Drain- source breakdown voltage	V _{(BR)DSS}	-60	-	-	V
$V_{GS} = 0 \text{ V}, I_{D} = -0.25 \text{ mA}$					
Gate threshold voltage, $V_{GS} = V_{DS}$	V _{GS(th)}	-1	-1.5	-2	
$I_{\rm D}$ = -460 µA, $T_{\rm i}$ = 25 °C					
Zero gate voltage drain current	l _{DSS}				μΑ
V_{DS} = -60 V, V_{GS} = 0 V, T_{j} = -40 °C		-	-	-0.1	
$V_{\rm DS}$ = -60 V, $V_{\rm GS}$ = 0 V, $T_{\rm j}$ = 25 °C		-	-0.1	-1	
$V_{DS} = -60 \text{ V}, V_{GS} = 0 \text{ V}, T_i = 150 \text{ °C}$		-	-	-100	
Gate-source leakage current	I _{GSS}	-	-10	-100	nA
$V_{GS} = -20 \text{ V}, V_{DS} = 0 \text{ V}$					
Drain-Source on-state resistance	R _{DS(on)}				Ω
$V_{GS} = -4.5 \text{ V}, I_D = -1.5 \text{ A}$		_	0.3	0.45	
$V_{GS} = -10 \text{ V}, I_{D} = -1.8 \text{ A}$		_	0.21	0.3	

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Electrical Characteristics					
Parameter	Symbol	Values		Unit	
at T_i = 25 °C, unless otherwise specified		min.	typ.	max.	
Dynamic Characteristics		_		_	
Transconductance	g_{fs}	1	3	-	S
$V_{DS} \ge 2^* I_D^* R_{DS(on)max}$, $I_D = -1.8 \text{ A}$					
Input capacitance	C _{iss}	-	365	460	pF
$V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$					
Output capacitance	Coss	-	105	135	
$V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$					
Reverse transfer capacitance	C_{rss}	-	40	50	
$V_{GS} = 0 \text{ V}, V_{DS} = -25 \text{ V}, f = 1 \text{ MHz}$					
Turn-on delay time	t _{d(on)}	-	13	20	ns
$V_{DD} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -1.8 \text{ A},$					
$R_{\rm G}$ = 6 Ω					
Rise time	t _r	-	30	45	
$V_{DD} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -1.8 \text{ A},$					
$R_{\rm G} = 6 \Omega$					
Turn-off delay time	t _{d(off)}	-	200	300	
$V_{DD} = -30 \text{ V}, V_{GS} = -10 \text{ V}, I_{D} = -1.8 \text{ A},$					
$R_{\rm G} = 6 \Omega$					
Fall time	<i>t</i> _f	-	75	115	
$V_{DD} = -30 \text{ V}, \ V_{GS} = -10 \text{ V}, \ I_{D} = -1.8 \text{ A},$					
$R_{\rm G} = 6 \Omega$					



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Electrical Characteristics

Parameter	Symbol	Values		Unit	
at T_i = 25 °C, unless otherwise specified		min.	typ.	max.	
Dynamic Characteristics					
Gate charge at threshold	Q _{G(th)}	-	0.6	0.9	nC
$V_{DD} = -24 \text{ V}, I_{D} \ge -0.1 \text{ A}, V_{GS} = 0 \text{ to - 1 V}$, ,				
Gate charge at V _{gs} =5V	Q _{g(5)}	-	8	12	
$V_{\rm DD}$ = -24 V, $I_{\rm D}$ = -1.8 A , $V_{\rm GS}$ = 0 to -5 V					
Gate charge total	Q_g	-	14	21	nC
$V_{\rm DD}$ = -24 V, $I_{\rm D}$ = -1.8 A, $V_{\rm GS}$ = 0 to -10 V					
Gate plateau voltage	V _(plateau)	_	2.8	-	V
$V_{\rm DD}$ = -24 V, $I_{\rm D}$ = -1.8 A					

Reverse Diode

Inverse diode continuous forward current	IS	-	-	-1.8	А
T _A = 25 °C					
Inverse diode direct current,pulsed	I _{SM}	-	-	-7.2	
_T _A = 25 °C					
Inverse diode forward voltage	V_{SD}	-	-0.95	-1.2	V
$V_{GS} = 0 \text{ V}, I_{F} = -3.6 \text{ A}$					
Reverse recovery time	$t_{\rm rr}$	-	100	150	ns
$V_{R} = -30 \text{ V}, I_{F} = I_{S}, di_{F}/dt = 100 \text{ A/}\mu\text{s}$					
Reverse recovery charge	Q _{rr}	_	0.2	0.3	μC
$V_{R} = -30 \text{ V}, I_{F} = I_{S}, di_{F}/dt = 100 \text{ A/}\mu\text{s}$					

Preliminary data

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